

SIGC42T60NC

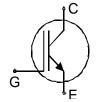
IGBT Chip in NPT-technology

FEATURES:

- 600V NPT technology
- 100µm chip
- positive temperature coefficient
- easy paralleling

This chip is used for:

• IGBT-Modules



Applications:

• drives

Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code	
SIGC42T60NC	600V	50A	6.5 x 6.5 mm ²	sawn on foil	Q67041-A4692-	
31GC42100NC	000V 30A	JUA	0.5 x 0.5 111111	Sawii Oil IOII	A001	

MECHANICAL PARAMETER:

Raster size	6.5 x 6.5				
Area total / active	42.25 / 35.6]			
Emitter pad size	2x(3.0x2.85)]			
Gate pad size	0.8 x 1.5				
Thickness	100	μm			
Wafer size	150	mm			
Flat position	90	deg			
Max.possible chips per wafer	334				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm Al Si 1%	3200 nm Al Si 1%			
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	Al, ≤500μm				
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



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MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	600	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	150	Α
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
i didilictei		Conditions	min.	typ.	max.	
Collector-emitter breakdown voltage	$V_{(BR)CES}$	V _{GE} =0V, I _C =2mA	600			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =50A	1.7	2.0	2.5	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	I _C =1mA, V _{GE} =V _{CE}	4.5	5.5	6.5	
Zero gate voltage collector current	I _{CES}	V _{CE} =600V, V _{GE} =0V			2.5	μA
Gate-emitter leakage current	I _{GES}	V _{CE} =0V, V _{GE} =20V			120	nA

DYNAMIC CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
raiailletei	Syllibol		min.	typ.	max.	Ollit
Input capacitance	Ciss	V _{CE} =25V	-	2200	-	pF
Output capacitance	Coss	V _{GE} =0V	-	tbd	-	
Reverse transfer capacitance	Crss	f=1MHz	-	200	-	

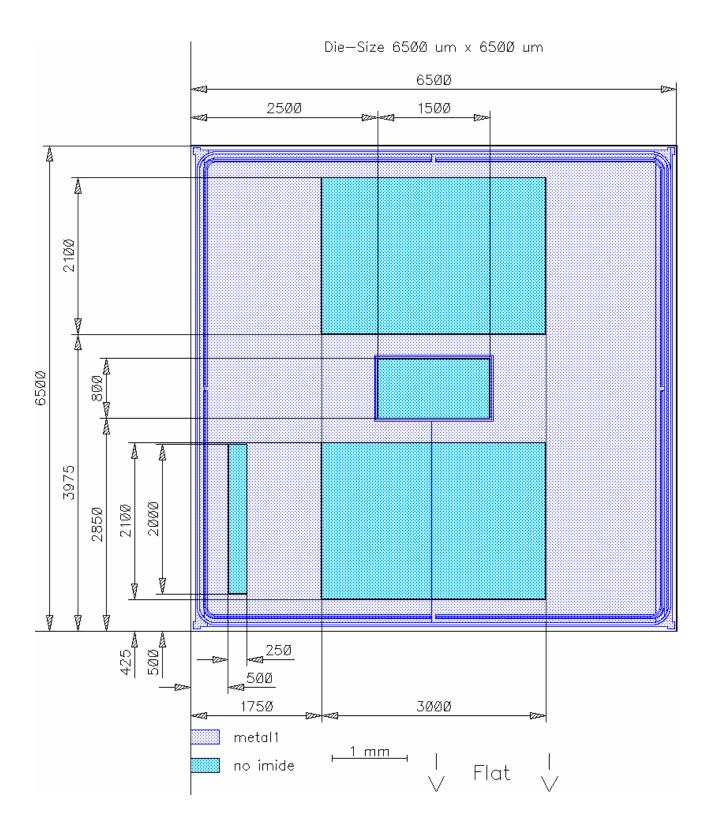
SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

Parameter	Symbol	Conditions 1)	Value			Unit
raiametei	Symbol		min.	typ.	max.	Oille
Turn-on delay time	$t_{d(on)}$	T _j =125°C V _{CC} =300V	-	43	-	ns
Rise time	t _r	I _C =50A	-	12	-	
Turn-off delay time	$t_{d(off)}$	$V_{\text{GE}} = \pm 15 \text{V}$ $R_{\text{G}} = 3.3\Omega$	-	130	-	
Fall time	t_{f}	NG-0.022	-	30	-	

 $^{^{1)}}$ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:





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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

FS 50 R06 YL4

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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